

Define $T = \frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}}$ t statistic

Realization of T on $X_1, \dots, X_n : t^*$ (e.g. $t^* = 3.71$)

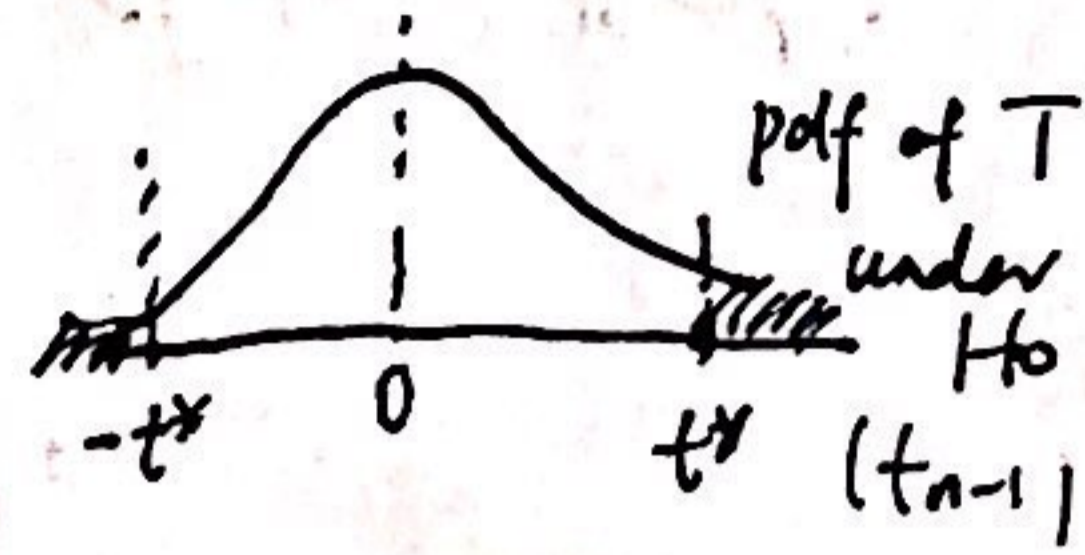
Decision: approach 1: p-value approach: dist of T under H_0 } \Rightarrow p-value realization t^*

p-value is a transformation of t^*

$$H_1: \mu \neq \mu_0 \Rightarrow P_{H_0}(|T| \geq |t^*|)$$

$$\text{or } H_1: \mu > \mu_0 \Rightarrow P_{H_0}(T \geq t^*)$$

$$\text{or } H_1: \mu < \mu_0 \Rightarrow P_{H_0}(T \leq t^*)$$



p-value: the prob. that T takes values 'more extreme' (determined by H_1) than t^* under H_0

Decision: if p-value $\leq \alpha \Rightarrow$ reject H_0

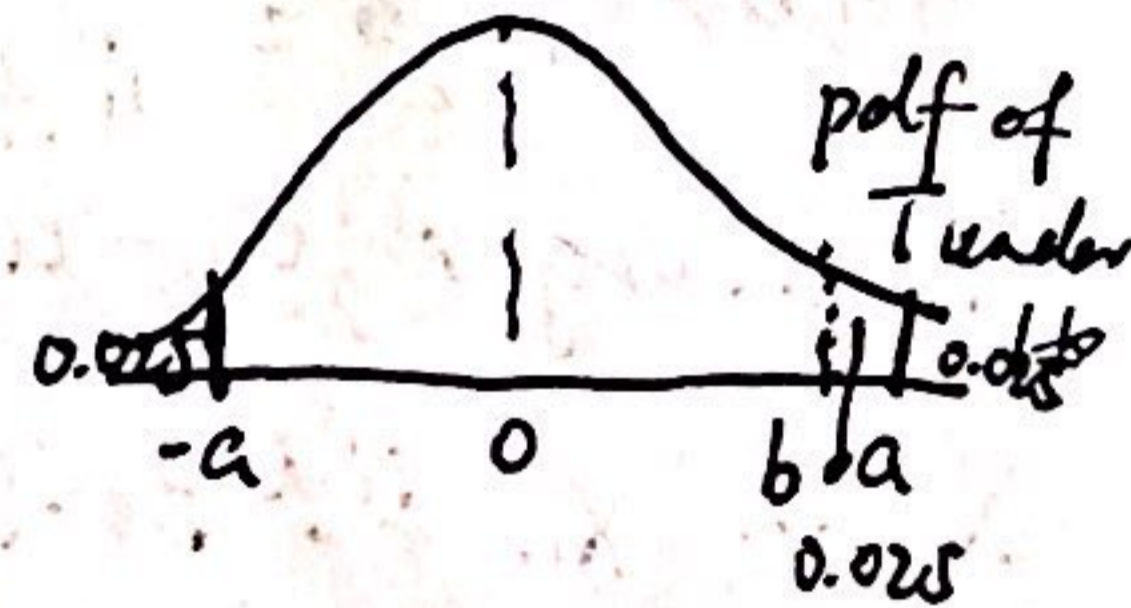
approach 2: rejection region based on α and the dist of T under H_0

e.g. $\alpha = 0.05$

$$H_1: \mu \neq \mu_0 : \text{rejection region } \{T \leq -a\} \cup \{T \geq a\}$$

$$\text{or } H_1: \mu > \mu_0 : \{T \geq b\}$$

$$\text{or } H_1: \mu < \mu_0 : \{T \leq -b\}$$



Decision: if $t^* \in$ rejection region \Rightarrow reject H_0

$$\text{Type I error} = P_{H_0}(\text{test rejects } H_0) = P_{H_0}(T \in \text{rejection region})$$

ideal case: rejection region is defined to have prob = α under H_0
 $\equiv \alpha$ (significance level)

$$\text{Type II error} = P_{H_1}(\text{test does not reject } H_0) = P_{H_0}(T \notin \text{rejection region}) \triangleq \beta$$

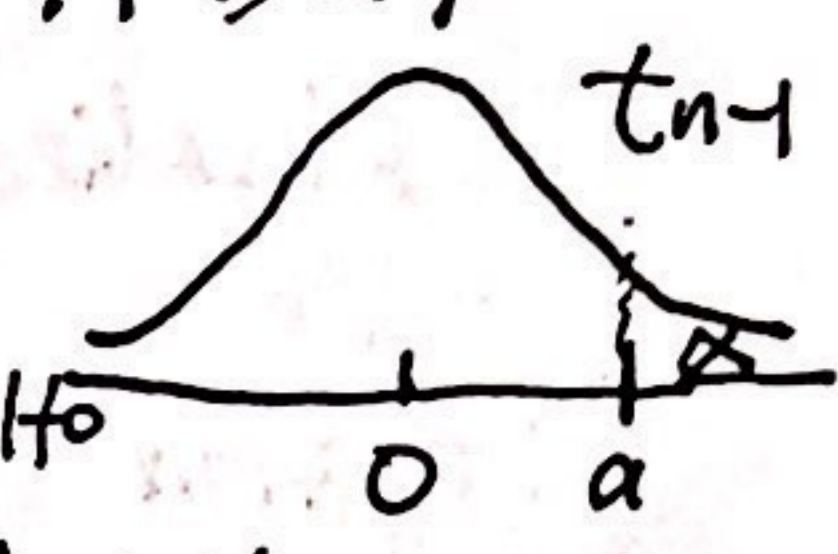
$$\text{power} \triangleq 1 - \beta = P_{H_1}(\text{test rejects } H_0) = P_{H_1}(T \in \text{rejection region})$$

computable when alternative hypothesis H_1 is simple, e.g. $H_1: \mu = \mu_1 \neq \mu_0$
 Under $H_0: \frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}} \sim t_{n-1}$ vs. Under $H_1: \frac{\bar{X}_n - \mu_1}{S_n/\sqrt{n}} \sim t_{n-1}$
 $\frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}} \equiv T$ vs. $\frac{\bar{X}_n - \mu_1}{S_n/\sqrt{n}} \equiv T + \frac{\mu_0 - \mu_1}{S_n/\sqrt{n}}$

WLOG, assume $\mu_1 > \mu_0$, the rejection region should take the form $\{T \geq a\}$

Given the sig. level α , find a s.t. $P_{H_0}(T \geq a) = \alpha$

a is the $(1-\alpha)$ quantile of t_{n-1} .



test: $T = \frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}} \Rightarrow$ realization $t^* = \frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}} \Rightarrow \begin{cases} \text{if } t^* \geq a, \text{ reject } H_0 \\ \text{o.w.}; \text{ do not reject } H_0 \end{cases}$

Type I error = α

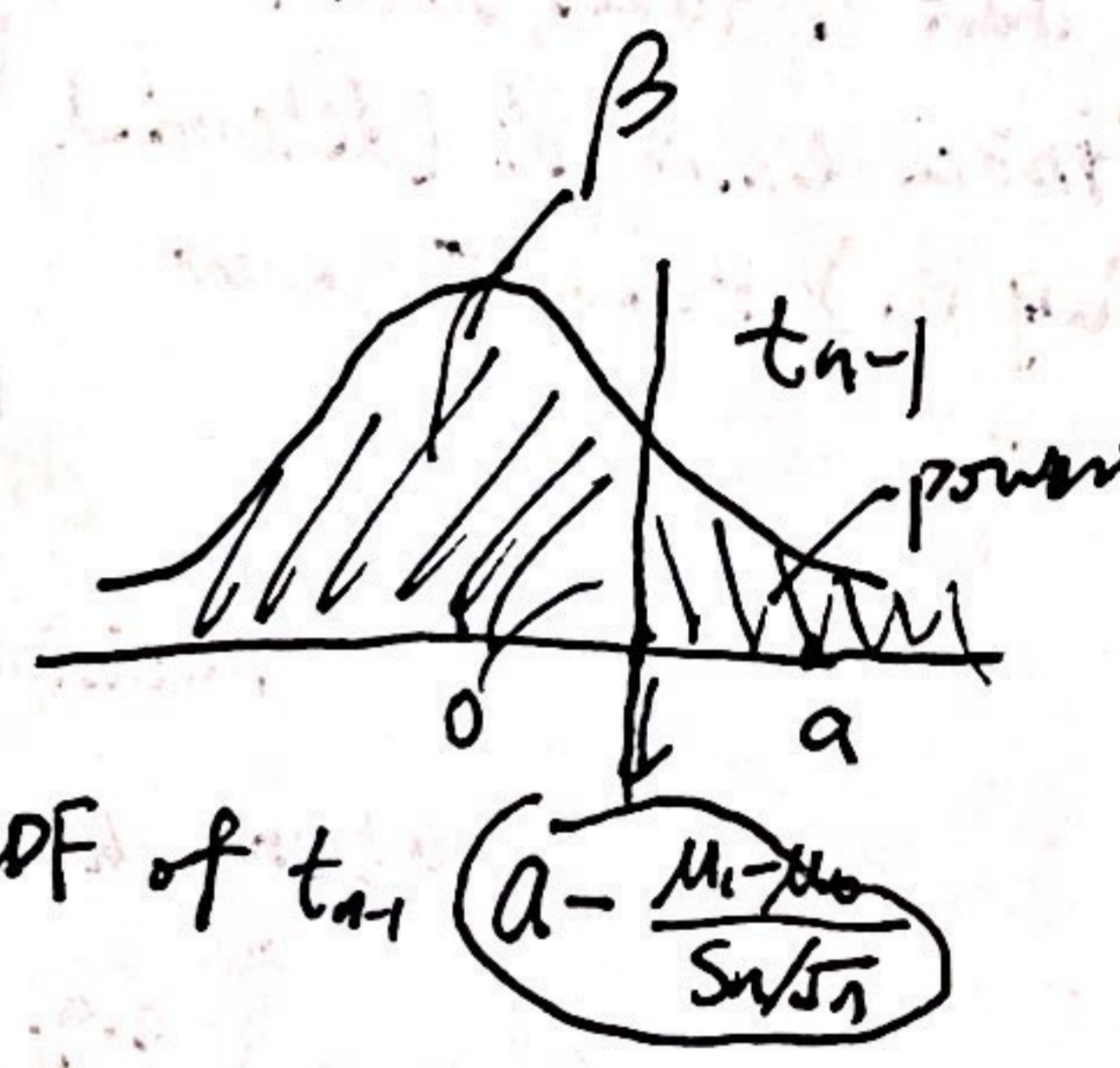
Type II error $\beta = P_{H_1}(T < a) = P_{H_1}\left(\frac{\bar{X}_n - \mu_0}{S_n/\sqrt{n}} < a\right)$

$\sim t_{n-1}$ under H_1

$= P_{H_1}\left(\frac{\bar{X}_n - \mu_1}{S_n/\sqrt{n}} + \frac{\mu_1 - \mu_0}{S_n/\sqrt{n}} < a\right)$

$\sim t_{n-1}$ under H_1

$= P_{H_1}\left(\frac{\bar{X}_n - \mu_1}{S_n/\sqrt{n}} < a - \frac{\mu_1 - \mu_0}{S_n/\sqrt{n}}\right)$



S_n is treated as fixed

$= F\left(a - \frac{\mu_1 - \mu_0}{S_n/\sqrt{n}}\right)$ where F is the CDF of t_{n-1}

power $1 - \beta = P_{H_1}(T \geq a) = \dots$

The larger $\mu_1 - \mu_0$ is, the greater the power.

$X_1, \dots, X_n \stackrel{iid}{\sim} \text{Ber}(p)$ $E[X_i] = p = IP(X_i = 1)$ $\text{var}[X_i] = p(1-p)$

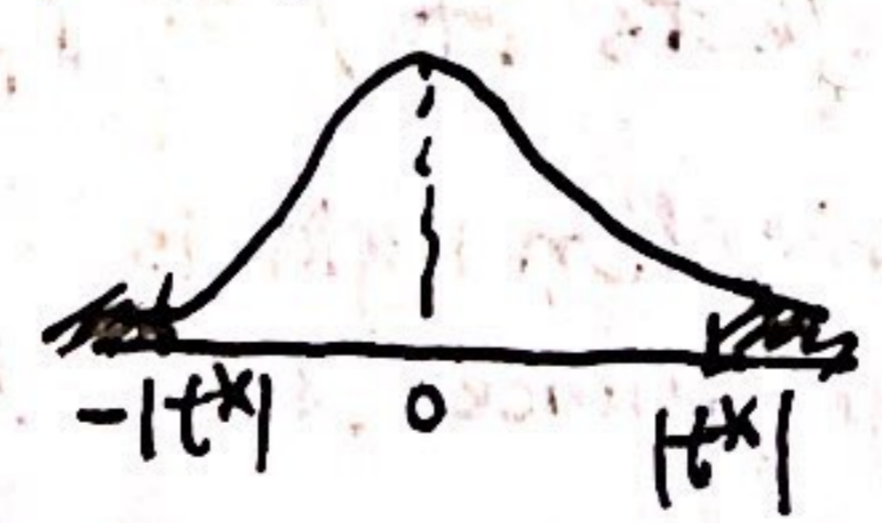
$H_0: p = p_0$ (e.g. $\frac{1}{2}$) $H_1: p \neq p_0$

$\hat{p} = \bar{X}_n$

under H_0 : by CLT $\hat{p} \stackrel{approx}{\sim} N\left(p_0, \frac{p_0(1-p_0)}{n}\right)$

$T = \frac{\hat{p} - p_0}{\sqrt{\frac{p_0(1-p_0)}{n}}} \stackrel{approx}{\sim} N(0, 1)$ realization t^*

p-value = $P_{H_0}(|T| \geq |t^*|) = \begin{cases} \text{if } \leq \alpha, \text{ reject } H_0 \\ \text{o.w.}, \text{ do not reject } H_0 \end{cases}$



$H_1: p \neq p_0$

$X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu_X, \sigma_X^2)$, $Y_1, \dots, Y_m \stackrel{iid}{\sim} N(\mu_Y, \sigma_Y^2)$

$X_1, \dots, X_n, Y_1, \dots, Y_m$ independent

$H_0: \mu_X = \mu_Y$ $H_1: \mu_X \neq \mu_Y$

$\mu_X - \mu_Y = 0$

Test statistic: $\hat{\mu}_X - \hat{\mu}_Y = \bar{X}_n - \bar{Y}_m \sim N(\mu_X - \mu_Y, \frac{\sigma_X^2}{n} + \frac{\sigma_Y^2}{m})$

Under H_0 : $\bar{X}_n - \bar{Y}_m \sim N(0, \frac{\sigma_X^2}{n} + \frac{\sigma_Y^2}{m})$

$T = \frac{\bar{X}_n - \bar{Y}_m}{\sqrt{\frac{\sigma_X^2}{n} + \frac{\sigma_Y^2}{m}}} \sim N(0,1)$ assuming σ_X^2 and σ_Y^2 are known

realization t^*

p-value = $\begin{cases} P_{H_0}(|T| \geq |t^*|) & \text{if } H_1: \mu_X \neq \mu_Y \\ P_{H_0}(T \geq t^*) & \text{if } H_1: \mu_X > \mu_Y \\ P_{H_0}(T \leq t^*) & \text{if } H_1: \mu_X < \mu_Y \end{cases}$

Two-sample t test: $\sigma_X^2 = \sigma_Y^2$ (additional assumption)

pooled sample variance = $\frac{(n-1)S_X^2 + (m-1)S_Y^2}{n+m-2} = \frac{\sum_{i=1}^n (X_i - \bar{X}_n)^2 + \sum_{i=1}^m (Y_i - \bar{Y}_m)^2}{n+m-2}$

Recall: $\frac{(n-1)S_X^2}{\sigma^2} \sim \chi_{n-1}^2$, $\frac{(m-1)S_Y^2}{\sigma^2} \sim \chi_{m-1}^2$, $S_X^2 \perp S_Y^2$

$\Rightarrow \frac{(n-1)S_X^2 + (m-1)S_Y^2}{\sigma^2} \sim \chi_{n+m-2}^2$ (1)

combined w/ $\frac{\bar{X}_n - \bar{Y}_m}{\sqrt{\frac{\sigma_X^2}{n} + \frac{\sigma_Y^2}{m}}} \stackrel{H_0}{\sim} N(0,1)$

$\parallel \sigma_X^2 = \sigma_Y^2$

$\frac{\bar{X}_n - \bar{Y}_m}{\sigma \sqrt{\frac{1}{n} + \frac{1}{m}}} \stackrel{H_0}{\sim} N(0,1)$ (2)

Based on the def of t distribution

(1) + (2) \Rightarrow
 $\bar{X}_n \perp S_X^2$
 $\bar{Y}_m \perp S_Y^2$

$\frac{\frac{\bar{X}_n - \bar{Y}_m}{\sigma \sqrt{\frac{1}{n} + \frac{1}{m}}}}{\sqrt{\frac{(n-1)S_X^2 + (m-1)S_Y^2}{\sigma^2} / (n+m-2)}} \stackrel{H_0}{\sim} t_{n+m-2}$

$\stackrel{H_0}{\sim} t_{n+m-2}$

"two-sample t statistic"

$\frac{\bar{X}_n - \bar{Y}_m}{\sqrt{\frac{(n-1)S_X^2 + (m-1)S_Y^2}{n+m-2} (\frac{1}{n} + \frac{1}{m})}} = \frac{\bar{X}_n - \bar{Y}_m}{\sqrt{S_p^2 (\frac{1}{n} + \frac{1}{m})}} \stackrel{H_0}{\sim} t_{n+m-2}$

Neyman - Pearson Lemma:

$$H_0: \theta = \theta_0 \quad \text{vs.} \quad H_1: \theta = \theta_1 \neq \theta_0$$

X_1, \dots, X_n iid ~~are~~ f_θ

$$L(\theta_0) = \prod_{i=1}^n f_{\theta_0}(X_i)$$

$$L(\theta_1) = \prod_{i=1}^n f_{\theta_1}(X_i)$$

The most powerful test statistic: $\frac{L(\theta_1)}{L(\theta_0)}$

The rejection region is $\frac{L(\theta_1)}{L(\theta_0)} \geq a$ where a is a threshold determined by sig. level α and the dist of $\frac{L(\theta_1)}{L(\theta_0)}$ under H_0